

Notice of References Cited	Application/Control No. 10/529,238		Applicant(s)/Patent Under Reexamination ARAKANE ET AL.	
	Examiner Brett A. Crouse		Art Unit 1794	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0055014	05-2002	Okada et al.	428/690
*	B	US-6,137,223	10-2000	Hung et al.	313/506
*	C	US-6,656,612	12-2003	Okada et al.	428/690
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	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

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	U	Matsushima et al., Current Applied Physics, (2005), Volume 5, Pages 305-308.
	V	Adachi et al., Organic Electronics, (2001), Volume 2, Pages 37-43.
	W	Tanaka et al., Japan Journal of Applied Physics, (2003), Volume 42, Pages 2737-2740.
	X	Machine Translation, JP 2000-169448, Fujino et al.

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.